

Search Notes

Application/Control No.

10/604,343

Examiner

Thien M. Le

Applicant(s)/Patent under
Reexamination

CHANG ET AL.

Art Unit

2876

SEARCHED

Class	Subclass	Date	Examiner
235	472.01	3/9/2005	LTM
	462.01		
	462.33		
	462.43		
	454		
	494		
	483		
	479		
	475		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	3/9/2005	LTM